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Tl₂Te and its relationship with Tl₅Te₃

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The crystal structure of Tl_2Te , dithallium telluride, has been determined by single-crystal X-ray diffraction. The analysis of the structure shows that this compound is the first known representative of a new crystal structure type. The structural relationship with the related Tl_5Te_3 phase is discussed.

Comment

Although the existence of Tl_2Te has been reported by many authors (Hahn & Klinger, 1949; Rabenau *et al.*, 1960; Vasilev *et al.*, 1968; Asadov *et al.*, 1977; Chami *et al.*, 1983), its crystal structure has remained undetermined and its existence has even been questioned (Chikashige, 1912; Klemm & Vogel, 1934; Oh & Lee, 1993). Using differential scanning calorimetry and powder X-ray diffraction, a study of the Tl–Te phase diagram was undertaken by Record *et al.* (1997), in which the existence of this phase was unambiguously confirmed. We report here on the crystal structure of Tl_2Te and its relation to Tl_5Te_3 .

The crystal structure of Tl_2Te can be described as two alternating types of (h0h) layers, similar to those found in the structure of Tl_5Te_3 [Fig. 1 in Schewe *et al.* (1989)]. Layer type *A* is a quasi-planar layer at $x + z = 0, \frac{1}{2}, 1$ and $\frac{3}{2}$. Layer type *B* is a puckered layer (thickness 2.5 Å) at $x + z = \frac{1}{4}, \frac{3}{4}, \frac{5}{4}$ and $\frac{7}{4}$. Layer *A* (Fig. 1) corresponds to the layer found at z = 0 and $\frac{1}{2}$ in Tl₅Te₃, while layer *B* (Fig. 1) corresponds to the layer found at $z = \frac{1}{4}$ and $\frac{3}{4}$ in Tl₅Te₃.

Layer A is described in Tl₅Te₃ as being formed from a $3^{2}434$ net of Te atoms centred by a 4^{4} net of Tl atoms. Bands of width ~18.3 Å containing basic motifs of this net are formed from atoms Tl3, Tl4, Te1, Te3, Te4 and Te5 in the structure of Tl₂Te. These bands are oriented along the *b* axis and are repeated twice in the [101] direction of the cell of Tl₂Te. Neighbouring bands are mutually shifted from the ideal infinite nets found in Tl₅Te₃ by a vector lying in the (*h*0*h*) plane having a length of ~4.85 Å (Fig. 1). The composition of layer A is identical in Tl₂Te (Tl₈Te₁₆) and in Tl₅Te₃ (Tl₄Te₈).

Layer *B* is described in Tl_5Te_3 as being formed from a 48² net of Tl atoms centred by a 4⁴ net of Te atoms. Bands of width ~14.7 Å containing basic motifs of this net are formed from atoms Tl1, Tl2, Tl5, Tl6, Tl7, Tl8, Tl9, Tl10, Tl11, Te2 and Te6 in the structure of Tl_2Te . The bands are also oriented along the *b* axis and are repeated twice in the [101] direction of the cell of Tl₂Te. Neighbouring bands are again mutually shifted by the same vector as in layer *A*, and are separated by atomic chains containing only Tl atoms. The composition of layer *B* in Tl₂Te is Tl_3eTe_6 , compared with Tl_1eTe_4 in Tl_5Te_3 . The overall composition changes from Tl_5Te_3 to Tl_2Te .

The shears in layers A and B occur so that they form (002) shear planes. The stacking of layers A and B in the structure of Tl_2Te , and the relation between the elementary cells of Tl_2Te and Tl_5Te_3 , are given in Fig. 2.

The structure of Tl_5Te_3 has also been described as containing infinite straight Te-Tl-Te chains, with Tl-Te distances of 3.15 Å, and quasi-molecular Tl₂Te groups, with Tl-Te distances of 3.16 Å. These chains propagate along the direction perpendicular to layers A and B. They can also be identified in the structure of Tl₂Te. However, they are finite (Tl4-Te2-Tl3-Te6-Tl3-Te2-Tl4), because of the shears in the A and B layers, and distorted (Tl-Te distances between 3.14 and 3.34 Å). The Tl₂Te groups can also be found in the structure of Tl₂Te. However, the Tl-Te distance in the group varies between 3.15 and 3.30 Å.



Figure 1

The structure of Tl_2 Te viewed in the direction ~[301]. Two basic units, the planar layer A and the puckered layer B, are shown. Open circles indicate Tl atoms and filled circles indicate Te atoms. Only the Te net in layer A and the Tl net in layer B are shown. The position of the shear plane is marked by a dashed line in each unit. The shear vector between two Tl₃Te₃-like regions is also shown.

The coordination of Tl and Te atoms in the structure of Tl₂Te is derived from that in the structure of Tl₅Te₃. The Tl atoms lying in the A layer of the Tl₅Te₃ structure are coordinated by a Te_{4+2} octahedron in the first sphere and by a Tl_8 cube in the second sphere. This coordination is nearly preserved in the Tl₂Te structure for atom Tl3, with slightly longer Tl–Te distances (3.30–3.42 Å) in the Te₆ octahedron and in the deformed Tl₈ cube (Tl-Tl distances of 3.82-4.09 Å). For atom Tl4, lying on the shear plane, the coordination is Te₅ (Tl-Te distances of 3.15–3.85 Å) and Tl₈ (Tl-Tl distances of 3.32–3.99 Å).

The Tl atoms in the B layer of the Tl_2Te structure are coordinated in the first sphere in a way similar to the Tl atoms in the *B* layer of the Tl_5Te_3 structure (distorted trigonal prism, Te₃Tl₃), with Tl-Te distances 3.15-3.54 Å and Tl-Tl distances of 3.35-3.73 Å. The TI9-TI4 (3.32 Å), TI9-TI8 (3.37 Å) and Tl10-Tl11 (3.35 Å) distances, found near the shear plane, correspond well with the distance in metallic Tl (3.35 Å).

The Te atoms in the A layer of the Tl_2Te structure lying outside the shear plane (atoms Te1, Te3 and Te4) are coordinated in a similar way to the Te atoms in the A layer of the Tl_5Te_3 structure (distorted bicapped trigonal prism, Tl_8), with Te-Tl distances of 3.15-3.58 Å. Atom Te5, lying on the shear plane, is coordinated by a distorted trigonal prism, Tl₆, with Te-Tl distances of 3.30-3.43 Å. Atom Te6, lying in the B layer outside the shear plane, is coordinated as in the Tl₅Te₃ structure, by a compressed bicapped tetragonal antiprism, with Te – Tl distances of 3.31-3.69 Å. Atom Te2, lying in the B layer close to the shear plane, is coordinated by a distorted tetragonal antiprism, with Te-Tl distances of 3.14-3.68 Å.

The crystal structure of Tl₂Te can be rationalized as being composed from regions with the structure of Tl₅Te₃ and regions which contain only Tl atoms, some of them showing Tl-Tl distances corresponding to metallic Tl. This description is further supported by the decomposition of Tl₂Te into Tl₅Te₃ and Tl on heating (Rabenau et al., 1960; Vasilev et al., 1968; Schewe et al., 1989). We have observed such phase transformation on a bulk sample of Tl₂Te, by powder diffraction and



Figure 2

The stacking of layers A and B in the structure of Tl_2Te viewed in the [010] direction. The Tl_2Te cell is shown by a solid line and the Tl_5Te_3 cell by a dashed line. Open circles indicate Tl atoms and filled circles indicate Te atoms. The position of the shear plane is marked by a dashed line.

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Rietveld refinement. After several days of the sample being exposed to air, it had nearly completely transformed to the Tl₅Te₃ phase and thallium oxides. According to the analysis of the Tl₅Te₃ structure by Schewe et al. (1989), the bond analysis of the Tl-Te system by Bhan & Schubert (1970), the chemical composition and the absence of Te-Te bonds in the structure of Tl_2Te , we expect that Tl has the oxidation state Tl^{1+} in Tl_2Te , and that the compound is metallic.

The structures of Tl₅Te₃ and Tl₂Te are closely related and, indeed, the crystal studied here was intergrown from two domains, one with the Tl₂Te structure and the other having a cubic face-centred lattice, with $a_c = 12.70$ Å. The diffraction pattern of the Tl₅Te₃ structure shows a strong face-centred cubic pseudosymmetry, with $a_c = 12.60$ Å, following the relationship $a_t = \frac{1}{2}(-a_c + c_c) = 8.98$ Å, $b_t = \frac{1}{2}(a_c + c_c) = 8.98$ Å and $c_t = b_c = 12.60$ Å. Some authors have even reported a diffraction pattern corresponding to a cubic lattice, with a lattice parameter of approximately 12.60 Å (Man et al., 1971; Anseau, 1973).

The Tl₅Te₃ phase shows a small range of homogeneity of several atomic% Tl. Whether, within this homogeneity range, the structure can change from pseudocubic to true cubic, and whether our second domain corresponds to that cubic structure or to the tetragonal Tl₅Te₃ structure, cannot be answered here, because of the small size of the second domain. The monoclinic cell of the Tl₂Te structure can also be related to the cubic cell with $a_c = 12.70$ Å. However, the deviation from the cubic lattice is much greater than in the case of the tetragonal Tl₅Te₃ cell. We have observed the following relationship between the lattices of the first domain (monoclinic) and the second domain (cubic) with $a_c = 12.70$ Å: $a_m \sim \frac{1}{2}(-a_c + 2b_c)$ $(-c_c) = 15.55 \text{ Å}, b_m = \frac{1}{2}(-a_c + c_c) = 8.98 \text{ Å} \text{ and } c_m \sim 2a_c + b_c$ $+ 2c_c = 28.40$ Å.

Experimental

The analytical sample was composed of weighed samples of pure thallium (Fluka, 4 N, 0.995 g) and pure tellurium (Fluka, 5 N, 0.299 g). Non-soluble impurities were removed from the tellurium by filtration under purified argon on silica wool. The thin oxide layer on the surface of the pure thallium pellets was removed using sulfuric acid baths (0.1 N) followed by rinsing in acetone. The alloy was then formed by direct fusion of the pure elements in a silica tube sealed under vacuum (10⁻¹ Pa). The composition of the alloy ($x_{\text{Te}} = 0.325$) was chosen to ensure that the Tl₂Te phase ($x_{Te} = 0.333$) was obtained even in the event of evaporation or oxidation of the thallium. Subsequent annealing was performed for 160 h at 553 K. For X-ray data collection, the crystal was covered with a protective layer of perfluoropolyalkyl ether (ABCR GmbH & Co.) to prevent its oxidation and decomposition.

Crystal data Tl_2

Tl ₂ Te
$M_r = 536.37$
Monoclinic, $C2/c$
$a = 15.6621 (9) \text{\AA}$
b = 8.9873 (4) Å
c = 31.196 (2) Å
$\beta = 100.761 \ (7)^{\circ}$
$V = 4313.9 (4) \text{ Å}^3$
Z = 44

 $D_x = 9.084 \text{ Mg m}^{-3}$ Mo $K\alpha$ radiation Cell parameters from 2000 reflections $\theta = 3-25^{\circ}$ $\mu = 89.10 \text{ mm}^{-1}$ T = 293 KParallelepiped, metallic dark grey $0.15 \times 0.03 \times 0.03$ mm

 Table 1

 Selected interatomic distances (Å).

Tl1-Te3	3.266 (3)	Tl5-Te2 ^{xi}	3.560 (4)
Tl1-Te4	3.356 (4)	T15-T16	3.592 (3)
Tl1-Te1	3.457 (4)	Tl6-Te4	3.175 (4)
Tl1-Tl7 ⁱ	3.508 (3)	Tl6-Te4 ^{xii}	3.453 (4)
Tl1-Tl1 ⁱⁱ	3.586 (2)	Tl6-Te1 ^{xii}	3.462 (3)
Tl1-Tl6 ⁱⁱⁱ	3.631 (3)	Tl6-Tl6 ^{xiii}	3.514 (3)
Tl2-Te4	3.241 (3)	Tl7—Te4 ^{viii}	3.151 (3)
Tl2-Te3	3.272 (4)	Tl7-Te4	3.297 (4)
Tl2-Te1	3.344 (4)	Tl7-Te6 ^{xi}	3.396 (3)
Tl2-Tl9 ^{iv}	3.460 (3)	Tl7-Tl11 ^v	3.421 (2)
Tl2-Tl5	3.514 (3)	Tl8-Te1	3.182 (3)
Tl2-Tl11 ^v	3.692 (3)	Tl8-Te3 ^{vii}	3.338 (4)
Tl3-Te6	3.3016 (17)	Tl8-Tl9 ^v	3.372 (3)
Tl3-Te2 ^{vi}	3.329 (3)	Tl8-Te5 ^{xiv}	3.407 (4)
Tl3-Te1	3.354 (4)	Tl8-Tl11 ^v	3.693 (3)
Tl3-Te3 ^{vii}	3.403 (3)	Tl8-Tl10 ^{vii}	3.739 (3)
Tl3-Te4 ^{vii}	3.417 (4)	Tl9-Te2 ^{xiv}	3.175 (3)
Tl3-Te4 ^{viii}	3.422 (3)	Tl9-Te5 ^{xiv}	3.283 (4)
Tl4-Te2 ^{ix}	3.154 (3)	T19-Te5	3.300 (4)
Tl4—Te1 ^{ix}	3.234 (4)	Tl10-Te3	3.229 (3)
Tl4—Tl9 ^{ix}	3.314 (2)	Tl10-Te5	3.293 (4)
Tl4-Te3 ^{ix}	3.363 (4)	Tl10-Tl11 ^{xv}	3.335 (3)
Tl4-Te5 ^x	3.676 (4)	Tl10-Te5 ^{xvi}	3.371 (4)
Tl4-Te5 ^{ix}	3.846 (4)	Tl11-Te2 ^{xiv}	3.170 (4)
Tl5-Te1 ^{xi}	3.186 (4)	Tl11-Te3 ^{xiv}	3.256 (4)
Tl5-Te3 ^{vi}	3.397 (4)	Tl11-Te5 ^{xiv}	3.433 (3)
Tl5-Tl7	3.560 (3)		

Symmetry codes: (i) $\frac{1}{2} + x, \frac{1}{2} + y, z$; (ii) $1 - x, y, \frac{3}{2} - z$; (iii) $\frac{1}{2} + x, y - \frac{1}{2}, z$; (iv) $\frac{1}{2} - x, \frac{3}{2} - y, 1 - z$; (v) $\frac{1}{2} - x, \frac{1}{2} - y, 1 - z$; (vi) $x - \frac{1}{2}, y - \frac{1}{2}, z$; (vii) x, y - 1, z; (viii) $\frac{1}{2} - x, y - \frac{1}{2}, \frac{3}{2} - z$; (ix) $x, 1 - y, z - \frac{1}{2}$; (x) $1 - x, y, \frac{1}{2} - z$; (xi) $x - \frac{1}{2}, \frac{1}{2} + y, z$; (xii) $\frac{1}{2} - x, \frac{1}{2} + y, \frac{3}{2} - z$; (xiii) x, y, -1, z; (viii) $1 - x, 2, \frac{1}{2} - z$; (xi) $x - \frac{1}{2}, \frac{1}{2} + y, z$; (xii) $1 - x, 2, \frac{1}{2} - z$; (xii) $x - \frac{1}{2}, \frac{1}{2} + y, z$; (xii) $1 - x, 2, -\frac{1}{2}, \frac{1}{2} - z$; (xii) $x - \frac{1}{2}, \frac{1}{2} + y, z$; (xii) $1 - x, 2, -\frac{1}{2}, \frac{1}{2} - z$; (xii) $x - \frac{1}{2}, \frac{1}{2} + y, z$; (xii) $1 - x, 2, -\frac{1}{2}, \frac{1}{2} - z$; (xii) $x - \frac{1}{2}, \frac{1}{2} + y, z$; (xii)

Data collection

Stoe IPDS diffractometer	$R_{\rm int} = 0.153$
φ oscillation scans	$\theta_{\rm max} = 25.9^{\circ}$
Absorption correction: analytical	$h = -19 \rightarrow 19$
(X-RED; Stoe & Cie, 1999)	$k = -11 \rightarrow 10$
$T_{\min} = 0.019, \ T_{\max} = 0.127$	$l = -38 \rightarrow 38$
12 622 measured reflections	200 standard reflections
3865 independent reflections	frequency: 10 min
1989 reflections with $F^2 > 2\sigma(F^2)$	intensity decay: none

Refinement

Refinement on F^2	$(\Delta/\sigma)_{\rm max} = 0.001$
R(F) = 0.107	$\Delta \rho_{\rm max} = 8.97 \text{ e} \text{ Å}^{-3}$
$wR(F^2) = 0.180$	$\Delta \rho_{\rm min} = -8.32 \text{ e} \text{ Å}^{-3}$
S = 2.37	Extinction correction: B-C type 1
1982 reflections	Gaussian isotropic (Becker &
150 parameters	Coppens, 1974)
Weighting scheme based on	Extinction coefficient: 0.005
measured s.u.'s	

Two non-coherent domains were identified in the crystal. The first domain had the Tl_2Te structure and the second had a cubic face-

centred lattice. The reflections of both domains were separated in the process of integrating the images. From 15 502 measured reflections of the first domain, 2880 reflections were rejected because of overlap with reflections of the second domain and mean $F^2/\sigma(F^2) = 4.6$. In the second domain, 7317 reflections were measured and mean $F^2/\sigma(F^2) = 1.9$. The *R* factors show no systematic deviation of different reflection groups from the mean, whether in dependence on hkl, F_{obs} or $sin(\theta)/\lambda$. No warnings of twinning were observed. The value of R_{int} and the difference Fourier maps were calculated using 1989 observed reflections. The highest peaks in the difference Fourier map are within 1 Å of the atom sites.

Data collection: *EXPOSE* in *IPDS Software* (Stoe & Cie, 1999); cell refinement: *CELL* in *IPDS Software*; data reduction: *ADDREF* and *SORTRF* in *Xtal*3.7 (Hall *et al.*, 2000), and *TWIN* in *IPDS Software*; program(s) used to solve structure: *SHELXS97* (Sheldrick, 1997); program(s) used to refine structure: *LSLS* in *Xtal*3.7; molecular graphics: *ATOMS* (Dowty, 1993); software used to prepare material for publication: *BONDLA* and *CIFIO* in *Xtal*3.7.

Supplementary data for this paper are available from the IUCr electronic archives (Reference: BR1351). Services for accessing these data are described at the back of the journal.

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